## Investigation of charge carrier lifetime temperature-dependence in 4H-SiC diodes

Velmre, Enn; Udal, Andres Silicon carbide and related materials 2006 2007 / p. 375-378
<a href="https://www.researchgate.net/publication/250348987">https://www.researchgate.net/publication/250348987</a> Investigation of Charge Carrier Lifetime Temperature-Dependence in 4H-SiC Diodes